

OptiMOS™ P2 Small-Signal-Transistor

Features

- P-channel
- Enhancement mode
- Super Logic Level (2.5V rated)
- Avalanche rated
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen-free according to IEC61249-2-21

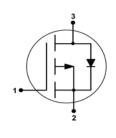






Product Summary

| V _{DS} | -20 | V | |
|-------------------------|-------------------------|------|---|
| R _{DS(on),max} | 150 | mΩ | |
| | V _{GS} =-2.5 V | 280 | |
| ID | | -1.5 | Α |



PG-SOT23



| Туре | Package | Tape and Reel Information | Marking | Lead Free | Packing |
|---------|----------|---------------------------|---------|-----------|---------|
| BSS215P | PG-SOT23 | H6327: 3000 pcs/ reel | YDs | Yes | Non dry |

Maximum ratings, at T_j =25 °C, unless otherwise specified

| Parameter | Symbol | Conditions | Value | Unit |
|-------------------------------------|-------------------------|--|-----------|-------|
| Continuous drain current | I _D | T _A =25 °C | -1.5 | А |
| | | T _A =70 °C | -1.18 | |
| Pulsed drain current | I _{D,pulse} | T _A =25 °C | -6 | |
| Avalanche energy, single pulse | E _{AS} | $I_{\rm D}$ =-1.5 A, $R_{\rm GS}$ =25 Ω | 11 | mJ |
| Reverse diode dv/dt | dv/dt | I_{D} =-1.5 A, V_{DS} =-16V, di/dt =-200A/ μ s, $T_{j,max}$ =150 °C | 6 | kV/µs |
| Gate source voltage | V_{GS} | | ±12 | V |
| Power dissipation ¹⁾ | P _{tot} | T _A =25 °C | 0.5 | W |
| Operating and storage temperature | $T_{\rm j},T_{\rm stg}$ | | -55 150 | °C |
| ESD Class | | JESD22-A114 -HBM | 0 (<250V) | V |
| Soldering Temperature | | | 260 °C | °C |
| IEC climatic category; DIN IEC 68-1 | | | 55/150/56 | °C |



| Parameter | Symbol | Conditions | Values | | | Unit |
|--|------------------|---------------------------------|--------|------|------|------|
| | | | min. | typ. | max. | |
| Thermal characteristics | | | | | | |
| Thermal resistance, junction - ambient | $R_{	ext{thJA}}$ | minimal footprint ¹⁾ | - | - | 250 | K/W |

Electrical characteristics, at $T_{\rm j}$ =25 °C, unless otherwise specified

Static characteristics

| Drain-source breakdown voltage | V _{(BR)DSS} | V _{GS} =0 V, I _D =-250 μA | -20 | - | - | V |
|----------------------------------|----------------------|---|------|------|------|----|
| Gate threshold voltage | $V_{\rm GS(th)}$ | V _{DS} =V _{GS} , I _D =-11 μA | -1.2 | -0.9 | -0.6 | |
| Drain-source leakage current | I _{DSS} | $V_{\rm DS}$ =-20V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C | 1 | 1 | -1 | μΑ |
| | | $V_{\rm DS}$ =-20V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =150 °C | - | - | -100 | |
| Gate-source leakage current | I _{GSS} | V _{GS} =-12V, V _{DS} =0V | - | - | -100 | nA |
| Drain-source on-state resistance | R _{DS(on)} | V _{GS} =2.5 V, I _D =-1.1 A | 1 | 166 | 280 | mΩ |
| | | V _{GS} =4.5 V, I _D =-1.5 A | ı | 105 | 150 | |
| Transconductance | $g_{	ext{fs}}$ | $ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 1.18~{\rm A}$ | - | 4.5 | - | S |

 $^{^{1)}}$ Performed on 40mm^2 FR4 PCB. The traces are 1mm wide, $70\mu\text{m}$ thick and 20mm long; they are present on both sides of the PCB.



| Parameter | Symbol Conditions | | Values | | Unit | |
|---------------------------------|----------------------|--|--------|-------|------|----|
| | | | min. | typ. | max. | |
| Dynamic characteristics | | | | | | |
| Input capacitance | Ciss | | - | 260 | 346 | pF |
| Output capacitance | Coss | V_{GS} =0 V, V_{DS} =-15 V, f =1 MHz | - | 102 | 135 | - |
| Reverse transfer capacitance | C _{rss} | | - | 85 | 128 | |
| Turn-on delay time | $t_{d(on)}$ | | - | 6.7 | - | ns |
| Rise time | t _r | V _{DD} =-10 V, V _{GS} =-4.5 V, | - | 9.7 | - | |
| Turn-off delay time | $t_{d(off)}$ | I_{D} =-1.5 A, R_{G} =6 Ω | - | 14.5 | - | |
| Fall time | t_{f} | 1 | - | 14.0 | - | |
| Gate Charge Characteristics | | T | Т | Т | Г | |
| Gate to source charge | Q _{gs} | $V_{\rm DD}$ =16 V, $I_{\rm D}$ =-1.5 A, $V_{\rm GS}$ =0 to -4.5 V | - | -0.49 | - | nC |
| Gate to drain charge | Q_{gd} | | - | -1.9 | - | |
| Gate charge total | Qg | | - | -3.6 | - | |
| Gate plateau voltage | $V_{\rm plateau}$ | | - | -1.9 | - | V |
| Reverse Diode | | | | | | |
| Diode continous forward current | Is | T _25 °C | - | - | -0.5 | Α |
| Diode pulse current | I _{S,pulse} | −T _A =25 °C | - | - | -6 | |
| Diode forward voltage | V _{SD} | V _{GS} =0 V, I _F =-1.5 A, T _j =25 °C | - | -0.8 | -1.1 | V |
| Reverse recovery time | t _{rr} | $V_{\rm R}$ =10 V, $I_{\rm F}$ =-1.5 A, $di_{\rm F}/dt$ =100 A/ μ s | - | 21.0 | - | ns |
| Reverse recovery charge | Q _{rr} | | - | -3.7 | - | nC |



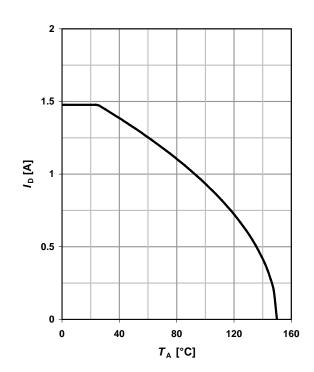
1 Power dissipation

$P_{tot} = f(T_A)$

0.5 0.375 \(\sum_{\text{\tint{\text{\tinit}}\text{\tinit}\\ \text{\text{\text{\text{\text{\text{\text{\text{\text{\tinit}\\ \text{\texi{\text{\ti}}\tint{\text{\text{\text{\text{\text{\tin}\tint{\text{\text{\ti}\til\titt{\text{\text{\text{\text{\text{\text{\text{\text{\til\til\til\titt{\text{\text{\text{\tilit{\texi\tint{\text{\texi}\til\tiint{\text{\tii}}\tint{\text{\tiint{\text{\tii}\tiint{\tint{\

2 Drain current

$$I_D = f(T_A); V_{GS} \le -4.5 \text{ V}$$



3 Safe operating area

$$I_D = f(V_{DS}); T_A = 25 \text{ °C}; D = 0$$

40

80

T_A [°C]

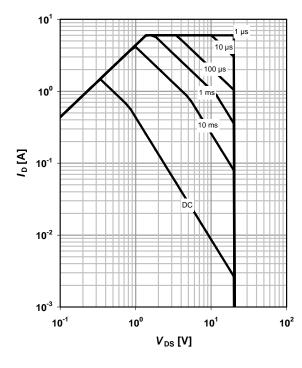
120

parameter: $t_{\rm p}$

0.125

0

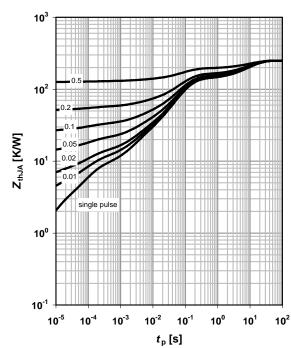
0



4 Max. transient thermal impedance

$$Z_{thJA}$$
=f(t_p)

parameter: $D=t_p/T$

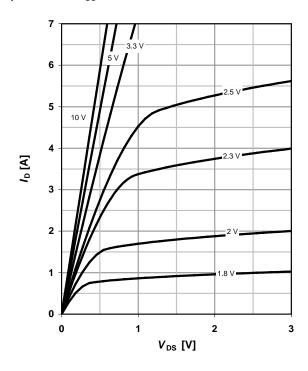




5 Typ. output characteristics

 $I_D=f(V_{DS}); T_j=25 \text{ °C}$

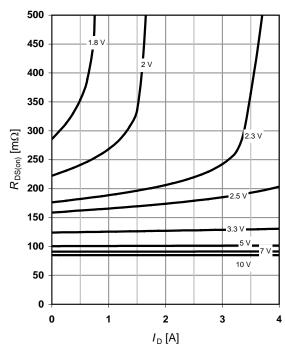
parameter: $V_{\rm GS}$



6 Typ. drain-source on resistance

 $R_{DS(on)}=f(I_D); T_j=25 \text{ °C}$

parameter: $V_{\rm GS}$

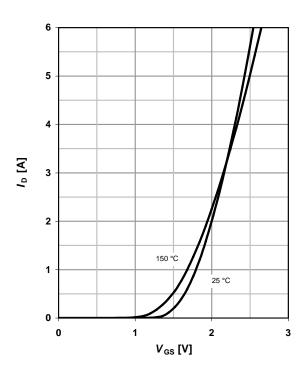


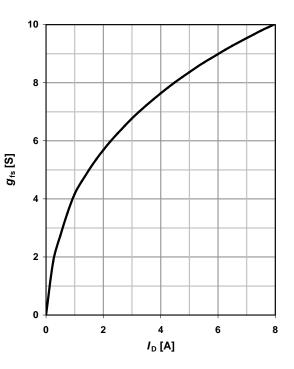
7 Typ. transfer characteristics

 I_{D} =f(V_{GS}); $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$

8 Typ. forward transconductance

 g_{fs} =f(I_D); T_j =25 °C







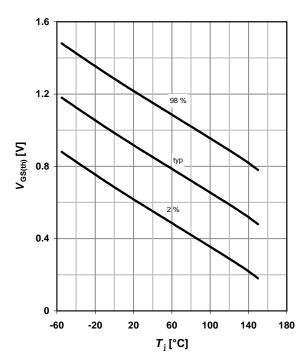
9 Drain-source on-state resistance

$$R_{DS(on)}$$
=f(T_j); I_D =-1.5 A; V_{GS} =-4.5 V

240 200 160 98 % 120 80 40 -60 -20 20 60 100 140 180 T_j [°C]

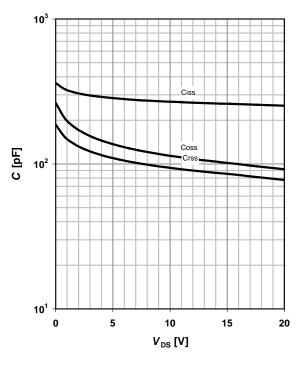
10 Typ. gate threshold voltage

$$V_{\rm GS(th)}$$
=f($T_{\rm j}$); $V_{\rm DS}$ =V_{GS}; $I_{\rm D}$ =-11 μ A parameter: $I_{\rm D}$



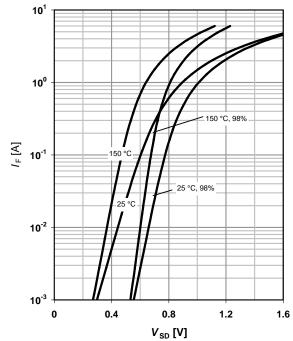
11 Typ. capacitances

$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz; T_j=25$$
°C



12 Forward characteristics of reverse diode

$$I_{F}=f(V_{SD})$$
 parameter: T_{j}

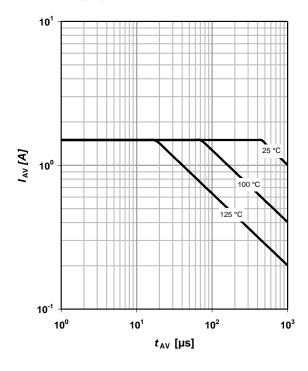




13 Avalanche characteristics

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

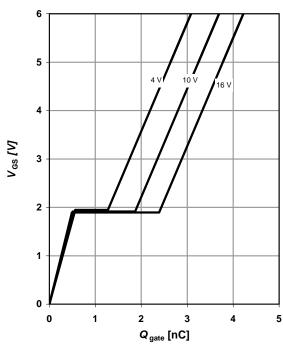
parameter: $T_{j(start)}$



14 Typ. gate charge

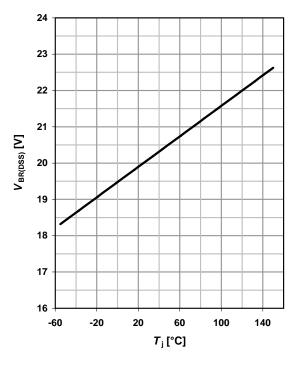
 V_{GS} =f(Q_{gate}); I_D =-1.5 A pulsed

parameter: $V_{\rm DD}$

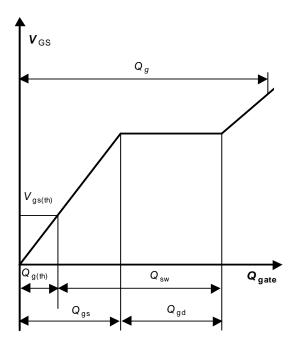


15 Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_i); I_D=250 \mu A$



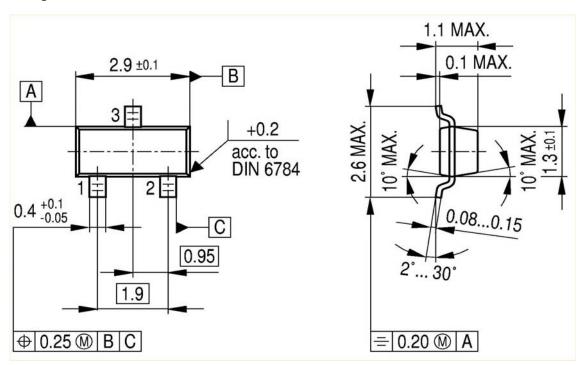
16 Gate charge waveforms





SOT23

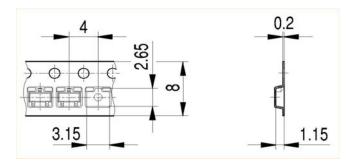
Package Outline:



Footprint:

0.9

Packaging:





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